Form PTO 1449 (Modified)	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE			ATTY DOCKET NO.		SERIAL NO.		
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LISTOF	KEFE	RENCES CITED BY AP	PLICANT	Toshichika TAKEI, et al.				
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U.S. PATENT DOCUMENTS								
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	ASS SUB FILING DATE CLASS IF APPROPRIATE		
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FOREIGN PATENT DOCUMENTS								
		DOCUMENT NUMBER	DATE	COUNTRY		TRANSLATION		
MAL	AO	2002-100562	04/05/02	Japan (with English Abstract and Computer Generated English Translation)		YES NO		
CAL	AP	11-204428	07/30/99	Japan (with English Abstract and Computer Generated English Translation)				
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)								
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*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.								